MOSFET - Power, Dual **N-Channel** 40 V, 7.4 mΩ, 52 A

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- NVMFD5C466NLWF Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter			Symbol	Value	Unit	
Drain-to-Source Voltage			V _{DSS}	40	V	
Gate-to-Source Voltage			V _{GS}	±20	V	
Continuous Drain		T _C = 25°C	I _D	52	Α	
Current R _{θJC} (Notes 1, 2, 3)	Steady	T _C = 100°C		37		
Power Dissipation	State	T _C = 25°C	P_{D}	38	W	
R _{θJC} (Notes 1, 2)		T _C = 100°C		19		
Continuous Drain		T _A = 25°C	I _D	15	Α	
Current R _{θJA} (Notes 1, 2, 3)	Steady	T _A = 100°C		11		
Power Dissipation	State	T _A = 25°C	P_{D}	3.0	W	
R _{θJA} (Notes 1, 2)		T _A = 100°C		1.5		
Pulsed Drain Current	T _A = 25	°C, t _p = 10 μs	I _{DM}	198	Α	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +175	°C	
Source Current (Body Diode)			Is	31.3	Α	
Single Pulse Drain-to-Source Avalanche Energy (T _J = 25°C, I _{L(pk)} = 3 A)			E _{AS}	72	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)		TL	260	°C		

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	4	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta,IA}$	47.3	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

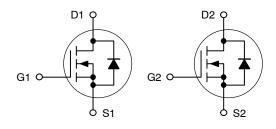


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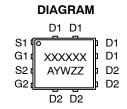
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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
40 V	7.4 m Ω @ 10 V	FO A
40 V	12.6 mΩ @ 4.5 V	52 A

Dual N-Channel







MARKING

= Assembly Location

= Year

W = Work Week = Lot Traceability

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

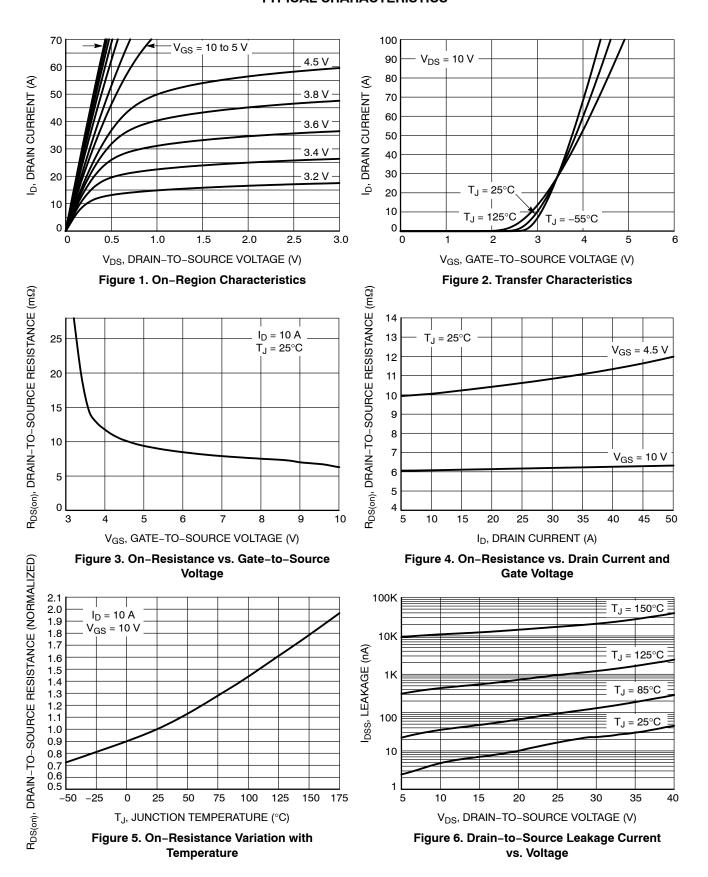
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS					•	•	•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				29		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V$	T _J = 25 °C			10	μΑ
		V _{DS} = 40 V	T _J = 125°C			250	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS}$	_S = 20 V			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 30 \mu A$		1.2		2.2	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-4.7		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 10 A		6.2	7.4	
		V _{GS} = 4.5 V	I _D = 10 A		10	12.6	$m\Omega$
Forward Transconductance	9FS	V _{DS} = 15 V, I _D	₎ = 25 A		33		S
CHARGES, CAPACITANCES & GATE RESIS	STANCE						•
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 25 V			997		pF
Output Capacitance	C _{OSS}				354		
Reverse Transfer Capacitance	C _{RSS}				13		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 4.5 V, V _{DS} = 32 V; I _D = 25 A			7.0		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 32 V; I _D = 25 A			16		
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V, V _{DS} = 32 V; I _D = 25 A			1.5		nC
Gate-to-Source Charge	Q_{GS}				2.3		
Gate-to-Drain Charge	Q_{GD}				2.2		
Plateau Voltage	V_{GP}				3.3		V
SWITCHING CHARACTERISTICS (Note 5)							
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 4.5 V, V_{DS} = 32 V, I_{D} = 25 A, R_{G} = 1.0 Ω			10		- ns
Rise Time	t _r				67		
Turn-Off Delay Time	t _{d(OFF)}				26		
Fall Time	t _f				60		
DRAIN-SOURCE DIODE CHARACTERISTIC	s						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V, I _S = 10 A	T _J = 25°C		0.9	1.2	
			T _J = 125°C		0.7		-
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dIS/dt = 100 A/μs, I _S = 25 A			20		ns
Charge Time	t _a				10		
Discharge Time	t _b				10		
Reverse Recovery Charge	Q _{RR}				8		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.

5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

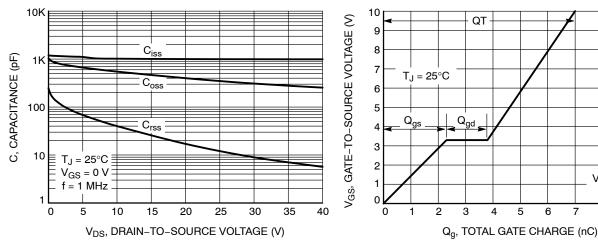


Figure 7. Capacitance Variation

Figure 8. Gate-to-Source vs. Total Charge

V_{DS} = 32 V

 $I_D = 25 A$

9

10

8

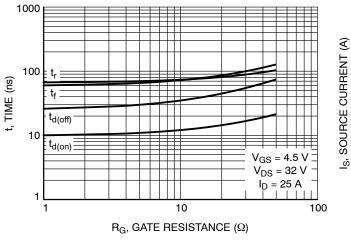


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

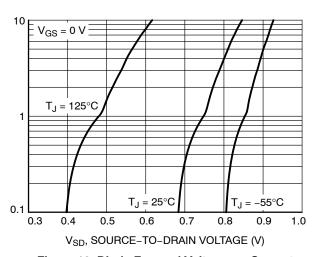


Figure 10. Diode Forward Voltage vs. Current

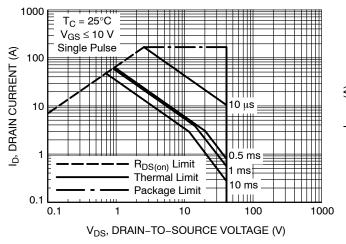


Figure 11. Maximum Rated Forward Biased Safe Operating Area

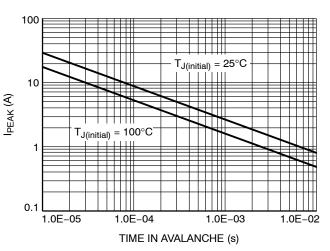


Figure 12. Maximum Drain Current vs. Time in Avalanche

TYPICAL CHARACTERISTICS

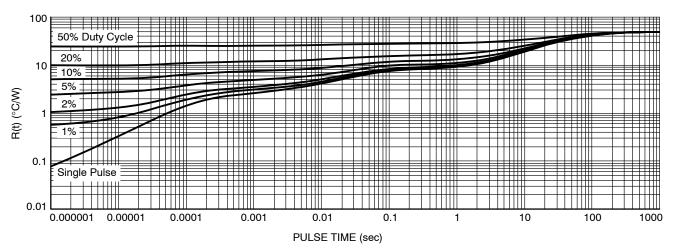


Figure 13. Thermal Response

DEVICE ORDERING INFORMATION

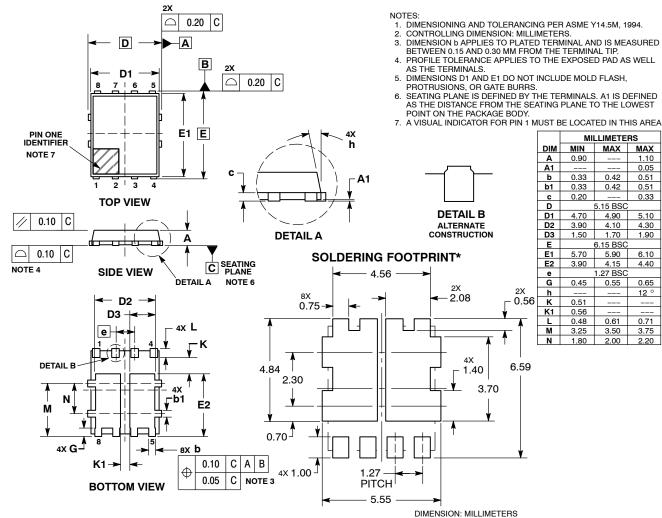
Device	Marking	Package	Shipping [†]
NVMFD5C466NLT1G	5C466L	DFN8 (Pb-Free)	1500 / Tape & Reel
NVMFD5C466NLWFT1G	466LWF	DFN8 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

DFN8 5x6, 1.27P Dual Flag (SO8FL-Dual)

CASE 506BT **ISSUE E**



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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